

19-0137: Rev 1; 3/94

MAXIM

Improved Low-Power, CMOS Analog Switches with Latches

General Description

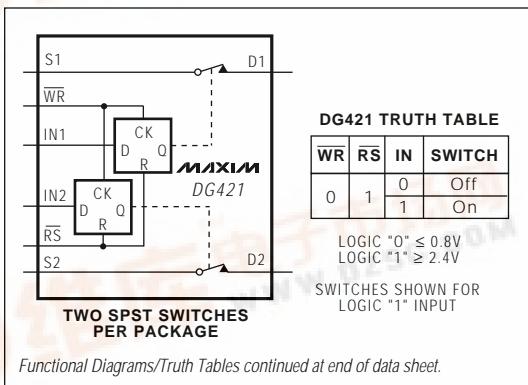
Maxim's redesigned DG421/DG423/DG425 monolithic analog switches now feature guaranteed on-resistance matching (3Ω max) between switches and on-resistance flatness over the signal range (4Ω max). These low on-resistance switches (20Ω typ) conduct equally well in both directions. They guarantee a low charge injection of $15pC$ maximum and an ESD tolerance of $2000V$ minimum per Method 3015.7. Off leakage current over temperature has also been reduced (less than $5nA$ at $+85^\circ C$).

The DG421/DG423/DG425 are precision, dual CMOS switches with latchable logic inputs that simplify interfacing with microprocessors (μ Ps). The single-pole/single-throw DG421 and double-pole/single-throw DG425 are normally open dual switches. The dual, single-pole/double-throw DG423 has two normally open and two normally closed switches. Fast switching times (175ns for t_{ON} and 145ns for t_{OFF}) and low power consumption ($35\mu W$ max) make these parts ideal for battery-powered applications requiring μ P-compatible switches. Operation is from a single $+10V$ to $+30V$ supply, or bipolar $\pm 4.5V$ to $\pm 20V$ supplies. Fabricated with the same $44V$ silicon-gate process, these switches have rail-to-rail signal handling capabilities.

Applications

Sample-and-Hold Circuits	Modems
Fax Machines	Test Equipment
Battery-Operated Systems	PBX, PABX
Guidance and Control Systems	Military Radios
Audio Signal Routing	Communication Systems

Functional Diagrams/Truth Tables

**DG421/DG423/DG425**

New Features

- ♦ Plug-In Upgrades for Industry-Standard DG421/DG423/DG425
- ♦ Improved $r_{DS(ON)}$ Match Between Channels (3Ω max)
- ♦ Guaranteed $r_{FLAT(ON)}$ Over Signal Range (4Ω max)
- ♦ Improved Charge Injection ($15pC$ max)
- ♦ Improved Off Leakage Current Over Temperature (< $5nA$ at $+85^\circ C$)
- ♦ Withstands Electrostatic Discharge (2000V min) per Method 3015.7

Existing Features

- ♦ Low $r_{DS(ON)}$ (35Ω max)
- ♦ Single-Supply Operation $+10V$ to $+30V$
Bipolar-Supply Operation $\pm 4.5V$ to $\pm 20V$
- ♦ Low Power Consumption ($35\mu W$ max)
- ♦ Rail-to-Rail Signal Handling Capability
- ♦ TTL/CMOS-Logic Compatible

Ordering Information

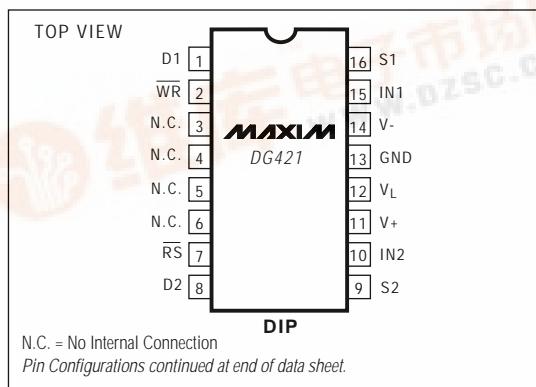
PART	TEMP. RANGE	PIN-PACKAGE
DG421CJ	0°C to +70°C	16 Plastic DIP
DG421CY	0°C to +70°C	16 SO
DG421C/D	0°C to +70°C	Dice*
DG421DJ	-40°C to +85°C	16 Plastic DIP
DG421DY	-40°C to +85°C	16 SO
DG421DK	-40°C to +85°C	16 CERDIP
DG421AK	-55°C to +125°C	16 CERDIP**

Ordering Information continued at end of data sheet.

* Contact factory for dice specifications.

**Contact factory for availability and processing to MIL-STD-883B.

Pin Configurations



Improved Low-Power, CMOS Analog Switches with Latches

ABSOLUTE MAXIMUM RATINGS

Voltage Referenced to V-						
V ₊	44V					
GND	25V					
V _L	(GND - 0.3V) to (V ₊ + 0.3V)					
Digital Inputs, V _S , V _D (Note 1)	(V ₋ - 2V) to (V ₊ + 2V)					
Current (any terminal, except S or D)30mA					
Continuous Current, S or D20mA					
Peak Current, S or D (pulsed at 1ms, 10% duty cycle max)	100mA					
Continuous Power Dissipation (T _A = +70°C)						
16-Pin Plastic DIP (derate 10.53mW/°C above +70°C)842mW					
20-Pin PLCC (derate 10.00mW/°C above +70°C)800mW					
16-Pin CERDIP (derate 10.00mW/°C above +70°C)800mW					
Operating Temperature Ranges						
DG42_C_	0°C to +70°C					
DG42_D_	-40°C to +85°C					
DG42_A_	-55°C to +125°C					
Storage Temperature Ranges						
DG42_C_ / DG42_D_	-65°C to +125°C					
DG42_A_	-65°C to +150°C					
Lead Temperature (soldering, 10sec)	+300°C					

Note 1: Signals on S, D, or IN exceeding V₊ or V₋ are clamped by internal diodes. Limit forward current to maximum current ratings.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

(V₊ = 15V, V₋ = -15V, V_L = +5V, GND = 0V, V_{INH} = +2.4V, V_{INL} = +0.8V, T_A = T_{MIN} to T_{MAX}, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	DG42_C, DG42_D			DG42_A			UNITS
			MIN	TYP	MAX	MIN	TYP	MAX	
SWITCH									
Analog Signal Range	V _{ANALOG}	(Note 3)	-15	15	-15	15			V
Drain-Source On-Resistance	r _{DS(ON)}	V ₊ = 13.5V, V ₋ = -13.5V, I _S = -10mA, V _D = ±10V	T _A = +25°C	20	45	20	35		Ω
			T _A = T _{MIN} to T _{MAX}		45		45		
On-Resistance Match Between Channels (Note 4)	Δr _{DS(ON)}	V ₊ = 16.5V, V ₋ = -16.5V, I _S = -10mA, V _D = ±10V	T _A = +25°C		3		3		Ω
			T _A = T _{MIN} to T _{MAX}		4		4		
On-Resistance Flatness (Note 4)	r _{FLAT(ON)}	V ₊ = 15V, V ₋ = -15V, I _S = -10mA, V _D = ±5V	T _A = +25°C		4		4		Ω
			T _A = T _{MIN} to T _{MAX}		5		5		
Source-Off Leakage Current (Note 5)	I _{S(OFF)}	V ₊ = 16.5V, V ₋ = -16.5V, V _D = ±15.5V, V _S = ±15.5V	T _A = +25°C	-0.50	-0.01	0.50	-0.25	-0.01	0.25
			T _A = T _{MIN} to T _{MAX}	-5		5	-10		10
Drain-Off Leakage Current (Note 5)	I _{D(OFF)}	V ₊ = 16.5V, V ₋ = -16.5V, V _D = ±15.5V, V _S = ±15.5V	T _A = +25°C	-0.50	-0.01	0.50	-0.25	-0.01	0.25
			T _A = T _{MIN} to T _{MAX}	-5		5	-10		10
Drain-On Leakage Current (Note 5)	I _{D(ON)}	V ₊ = 16.5V, V ₋ = -16.5V, V _D = ±15.5V, V _S = ±15.5V	T _A = +25°C	-1.0	-0.04	1.0	-0.40	-0.04	0.40
			T _A = T _{MIN} to T _{MAX}	-10		10	-20		20

Improved Low-Power, CMOS Analog Switches with Latches

ELECTRICAL CHARACTERISTICS (continued)

($V_+ = 15V$, $V_- = -15V$, $V_L = +5V$, GND = 0V, $V_{INH} = +2.4V$, $V_{INL} = +0.8V$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	(Note 2)	UNITS
INPUT							
Input Current with Input Voltage High	I_{INH}	$V_{IN} = 2.4V$, all others = 0.8V	-0.50	0.005	0.50	μA	
Input Current with Input Voltage Low	I_{INL}	$V_{IN} = 0.8V$, all others = 2.4V	-0.50	0.005	0.50	μA	
SUPPLY							
Power Supply Range	V_+, V_-	(Note 3)	± 4.5	± 20		V	
Positive Supply Current	I_+	All channels on or off, $V_+ = 16.5V$, $V_- = -16.5V$, $V_{IN} = 0V$ or 5V	$T_A = +25^\circ C$	-1.0	0.01	1.0	μA
			$T_A = T_{MIN}$ to T_{MAX}	-5.0		5.0	
Negative Supply Current	I_-	All channels on or off, $V_+ = 16.5V$, $V_- = -16.5V$, $V_{IN} = 0V$ or 5V	$T_A = +25^\circ C$	-1.0	-0.01	1.0	μA
			$T_A = T_{MIN}$ to T_{MAX}	-5.0		5.0	
Logic Supply Current	I_L	All channels on or off, $V_+ = 16.5V$, $V_- = -16.5V$, $V_{IN} = 0V$ or 5V	$T_A = +25^\circ C$	-1.0	-0.01	1.0	μA
			$T_A = T_{MIN}$ to T_{MAX}	-5.0		5.0	
Ground Current	I_{GND}	All channels on or off, $V_+ = 16.5V$, $V_- = -16.5V$, $V_{IN} = 0V$ or 5V	$T_A = +25^\circ C$	-1.0	-0.01	1.0	μA
			$T_A = T_{MIN}$ to T_{MAX}	-5.0		5.0	
DYNAMIC							
Turn-On Time	t_{ON}	Figure 2	$T_A = +25^\circ C$	150	250		ns
			$T_A = T_{MIN}$ to T_{MAX}		300		
Turn-Off Time	t_{OFF}	Figure 2			200		ns
Latch Timing	t_{WW}	$V_S = \pm 10V$, $R_L = 300\Omega$, $C_L = 35pF$, Figure 3	$T_A = +25^\circ C$	200			ns
	t_{DW}		$T_A = -55^\circ C$ to $+125^\circ C$	200			
			$T_A = +25^\circ C$	100			
			$T_A = -55^\circ C$ to $+125^\circ C$	100			
	t_{WD}		$T_A = +25^\circ C$	60			
			$T_A = -55^\circ C$ to $+125^\circ C$	100			
Break-Before-Make Interval (Note 3)	t_D	DG423, Figure 4	$T_A = +25^\circ C$	5	25		ns
Charge Injection (Note 3)	Q	$C_L = 10nF$, $V_G = 0V$, $R_G = 0\Omega$, Figure 5	$T_A = +25^\circ C$		10	15	pC
Off-Isolation Rejection Ratio (Note 6)	OIRR	$R_L = 100\Omega$, $C_L = 5pF$, $f = 1MHz$, Figure 6	$T_A = +25^\circ C$		72		dB
Crosstalk (Note 7)		$R_L = 50\Omega$, $C_L = 5pF$, $f = 1MHz$, Figure 7	$T_A = +25^\circ C$		90		dB
Drain-Off Capacitance	$C_{D(OFF)}$	$f = 1MHz$, Figure 8	$T_A = +25^\circ C$		12		pF
Source-Off Capacitance	$C_{S(OFF)}$	$f = 1MHz$, Figure 8	$T_A = +25^\circ C$		12		pF
Drain-On Capacitance	$C_{D(ON)}$	$f = 1MHz$, Figure 9	$T_A = +25^\circ C$		39		pF
Source-On Capacitance	$C_{S(ON)}$	$f = 1MHz$, Figure 9	$T_A = +25^\circ C$		39		pF

Note 2: Typical values are **for design aid only**, are not guaranteed, and are not subject to production testing. The algebraic convention, where the most negative value is a minimum and the most positive value a maximum, is used in this data sheet.

Note 3: Guaranteed by design.

Note 4: On-resistance match between channels and flatness are guaranteed only with bipolar-supply operation. Flatness is defined as the difference between the maximum and minimum value of on-resistance as measured at the extremes of the specified analog signal range.

Note 5: Leakage parameters $I_S(OFF)$, $I_D(OFF)$, and $I_D(ON)$ are 100% tested at the maximum rated hot temperature and guaranteed by correlation at $+25^\circ C$.

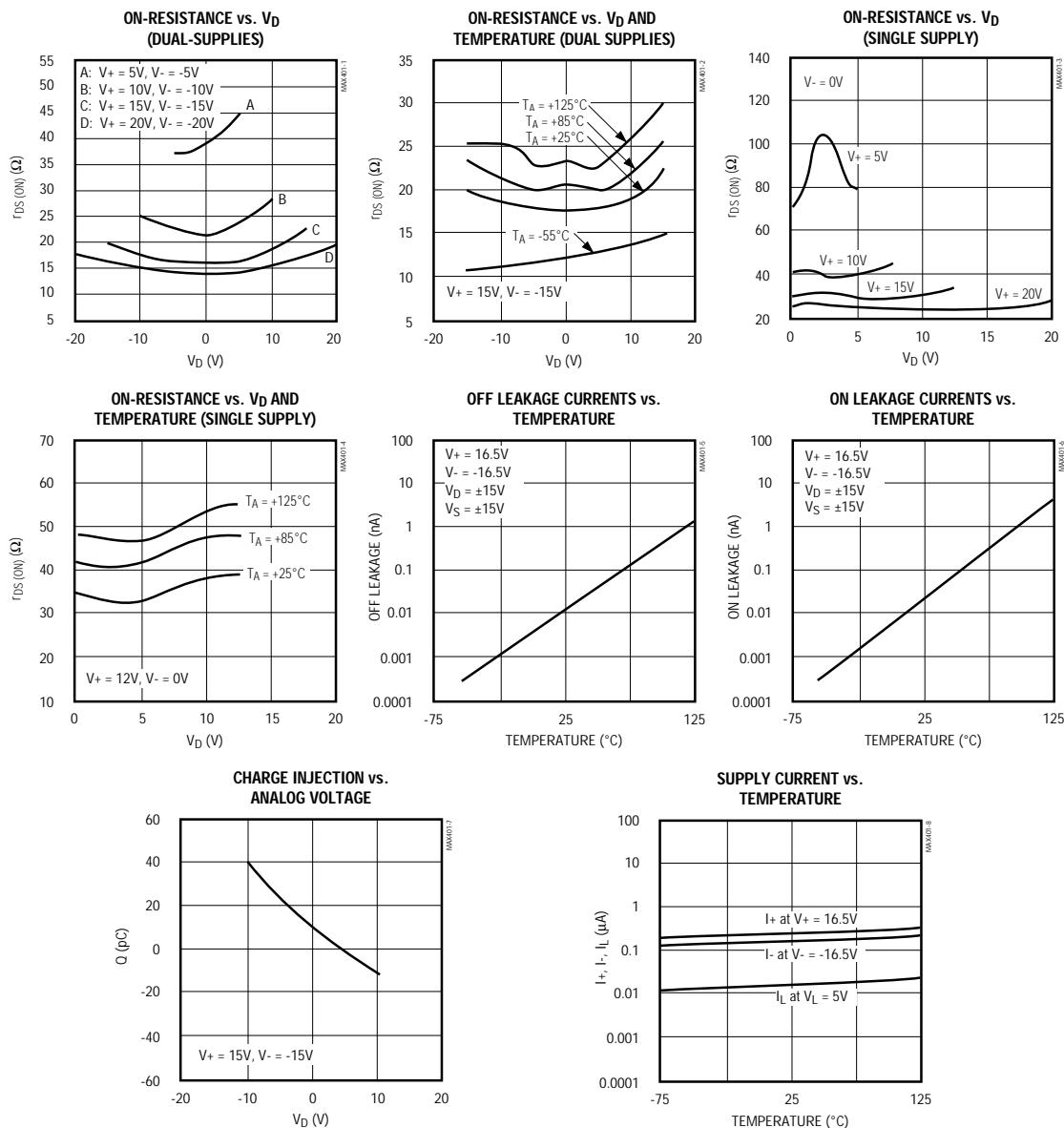
Note 6: Off-Isolation Rejection Ratio = $20\log(V_D/V_S)$, V_D = output, V_S = input to off switch.

Note 7: Between any two switches.

Improved Low-Power, CMOS Analog Switches with Latches

Typical Operating Characteristics

($T_A = +25^\circ\text{C}$, unless otherwise noted.)



Improved Low-Power, CMOS Analog Switches with Latches

Pin Descriptions

DG421			
PIN	NAME	FUNCTION	
1, 8	D1, D2	Drain Terminals	
2	WR	Write Select	
3, 4, 5, 6	N.C.	No Internal Connection	
7	RS	Reset Select	
9, 16	S1, S2	Source Terminals	
10, 15	IN1, IN2	Input Control	
11	V+	Positive Supply	
12	VL	Logic Supply	
13	GND	Ground	
14	V-	Negative Supply	
DG423/DG425			
DIP	PLCC	NAME	FUNCTION
1, 8, 3, 6	2, 10, 4, 8	D1-D4	Drain Terminals
2	3	WR	Write Select
16, 9, 4, 5	20, 12, 5, 7	S1-S4	Source Terminals
7	9	RS	Resets Select
15, 10	19, 13	IN1, IN2	Input Control
11	14	V+	Positive Supply
12	15	VL	Logic Supply
—	1, 6, 11, 16	N.C.	No Internal Connection
14	18	V-	Negative Supply
13	17	GND	Ground

Applications Information

Operation with Supply Voltages Other Than $\pm 15V$

The DG421/DG423/DG425 switches operate with $\pm 4.5V$ to $\pm 20V$ bipolar supplies or with a $+10V$ to $+30V$ single supply. In either case, analog signals ranging from V_+ to V_- can be switched. The *Typical Operating Characteristics* graphs illustrate typical analog-signal and supply-voltage on-resistance variations. The usual on-resistance temperature coefficient is $0.5\%/\text{ }^{\circ}\text{C}$ (typ).

Logic Inputs

These devices operate with a single positive supply or with bipolar supplies. They maintain TTL compatibility with supplies anywhere in the $\pm 4.5V$ to $\pm 20V$ range as long as $V_L = +5V$. If V_L is connected to V_+ or another supply at voltages other than $+5V$, the devices will operate at CMOS-logic-level inputs.

Overvoltage Protection

Proper power-supply sequencing is recommended for all CMOS devices. Do not exceed the absolute maximum ratings because stresses beyond the listed ratings may cause permanent damage to the devices. Always sequence V_+ on first, followed by V_L , V_- , and logic inputs. If power-supply sequencing is not possible, add two small, external signal diodes in series with supply pins for overvoltage protection (Figure 1). Adding diodes reduces the analog signal range to 1V below V_+ and 1V above V_- , without affecting low switch resistance and low leakage characteristics. Device operation is unchanged, and the difference between V_+ and V_- should not exceed $+44V$.

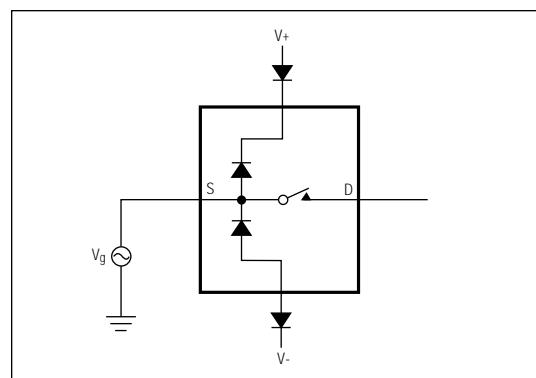


Figure 1. Overvoltage Protection Using External Blocking Diodes

Improved Low-Power, CMOS Analog Switches with Latches

Timing Diagrams/Test Circuits

V_{OUT} is the steady-state output with the switch on. Feedthrough via switch capacitance may result in spikes at the leading and trailing edge of the output waveform.

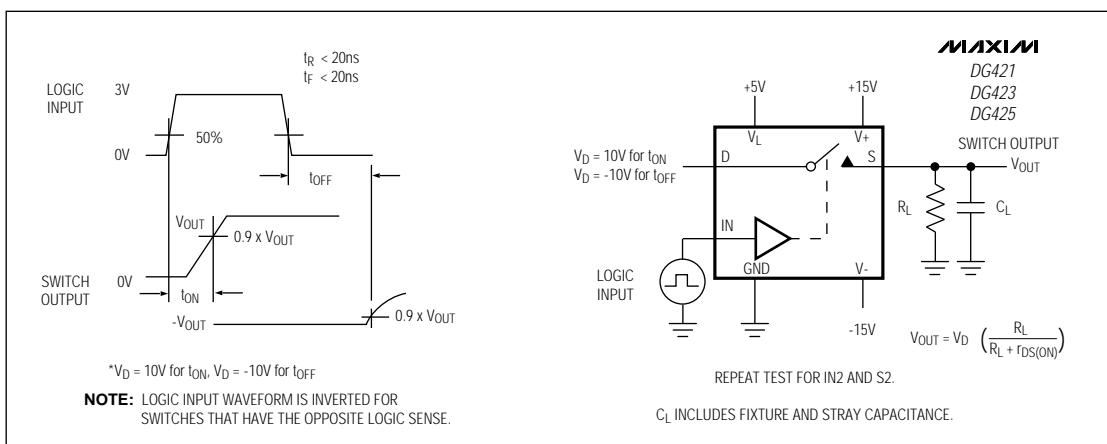


Figure 2. Switching Time

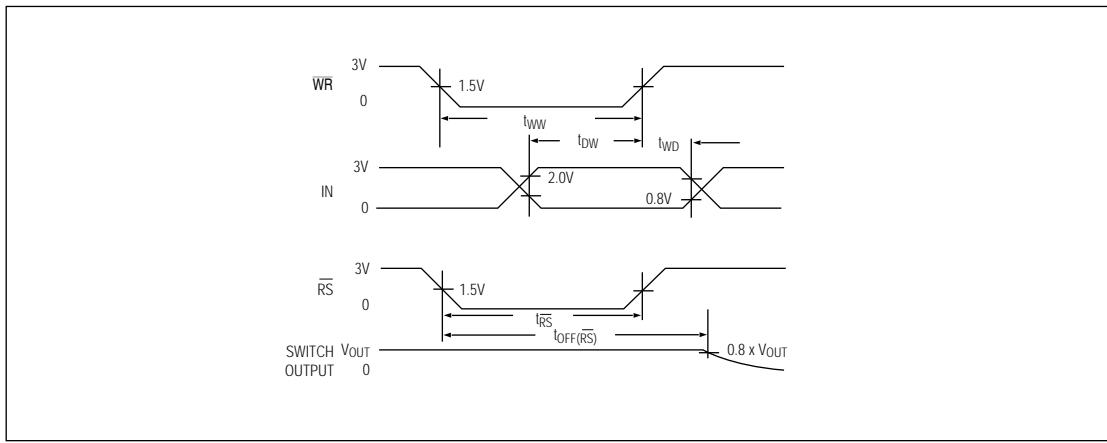


Figure 3. Latch Timing

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Timing Diagrams/Test Circuits (continued)

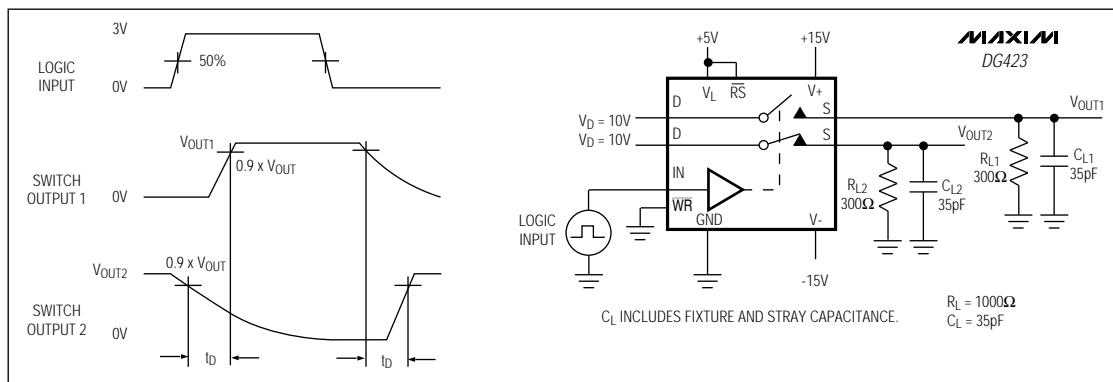


Figure 4. DG423 Break-Before-Make Interval

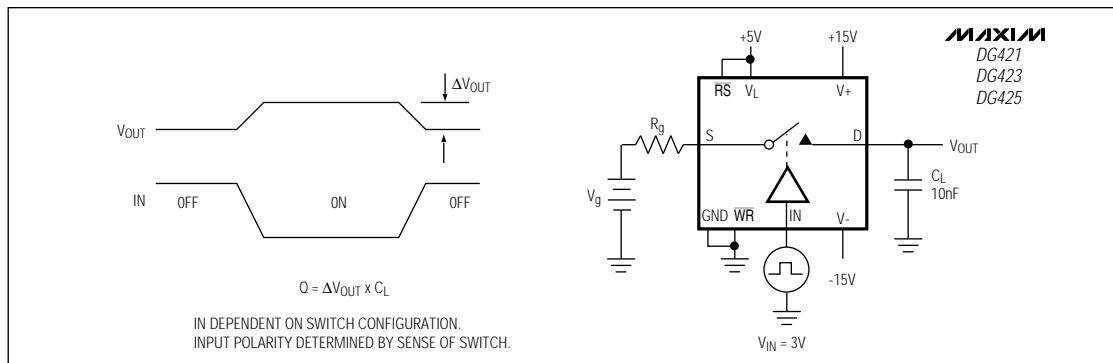


Figure 5. Charge Injection

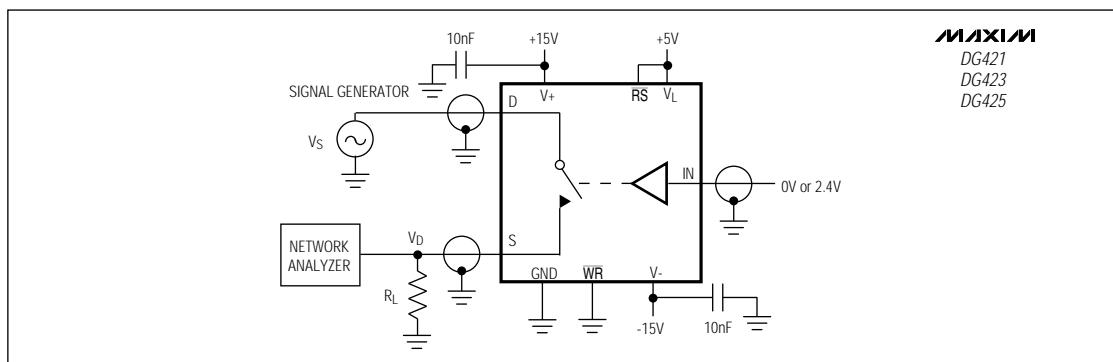


Figure 6 . Off-Isolation Rejection Ratio

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Timing Diagrams/Test Circuits (continued)

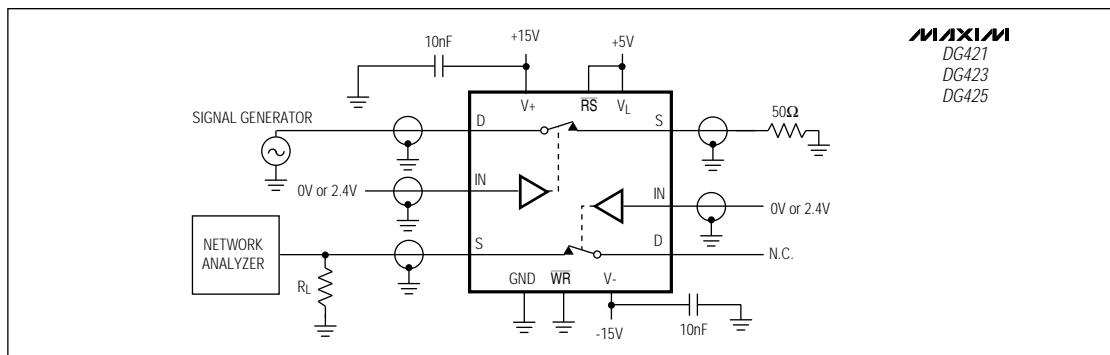


Figure 7. Crosstalk

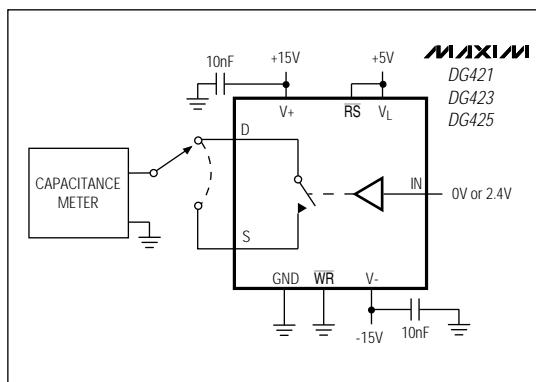


Figure 8. Drain/Source-Off Capacitance

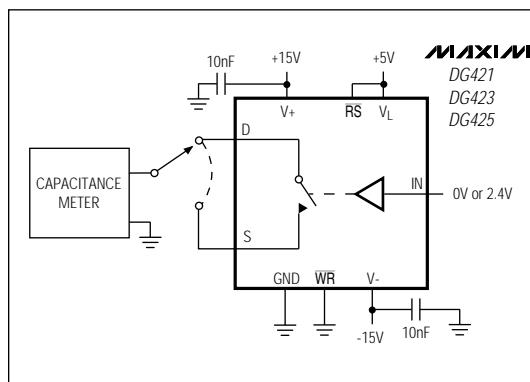
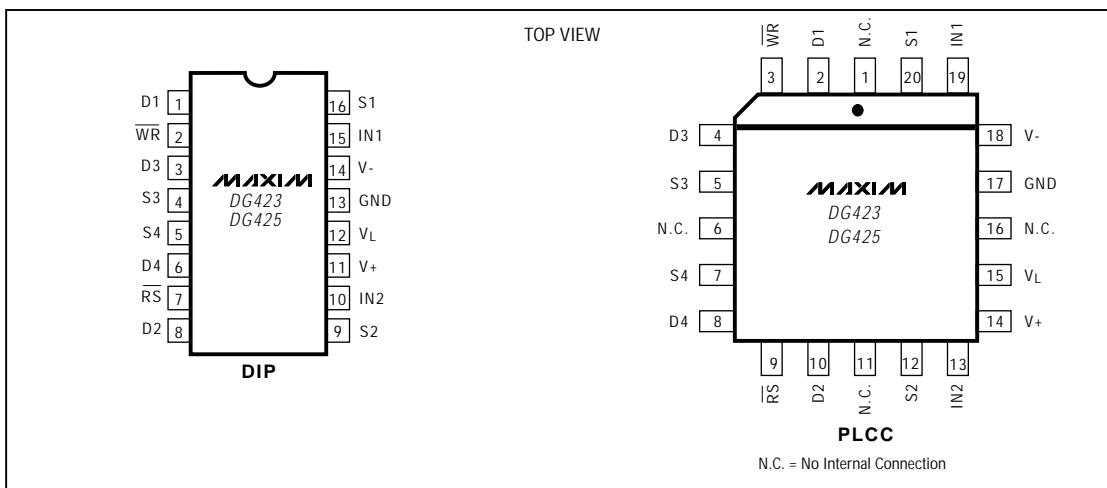


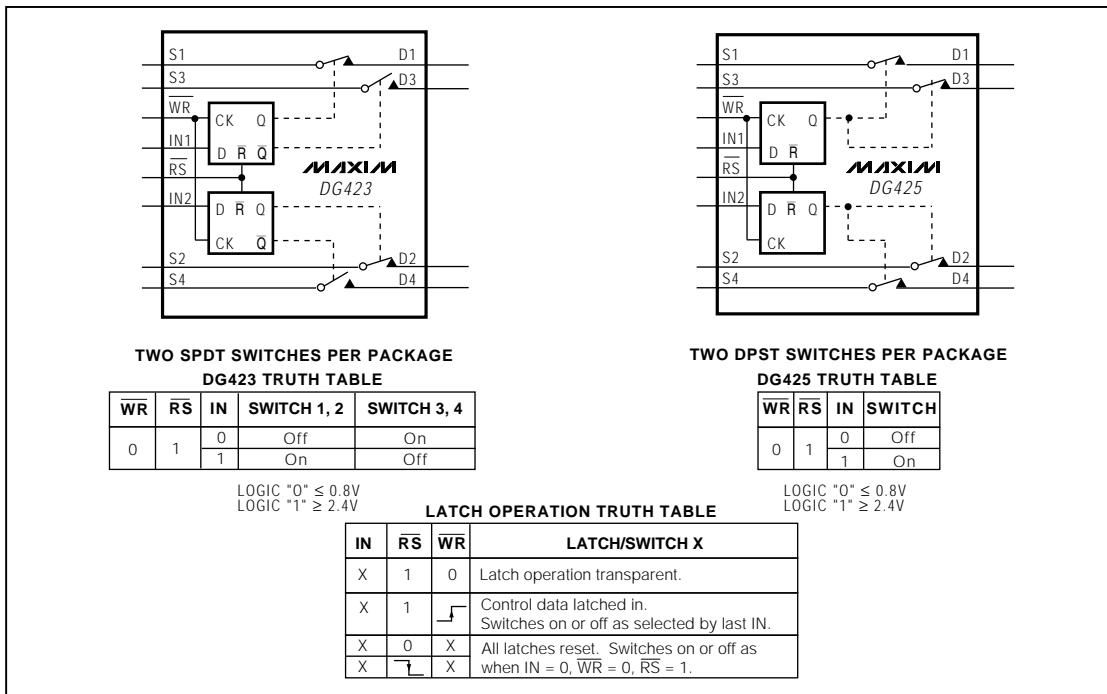
Figure 9. Drain/Source-On Capacitance

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Pin Configurations (continued)



Functional Diagrams/Truth Tables (continued)



Improved Low-Power, CMOS Analog Switches with Latches

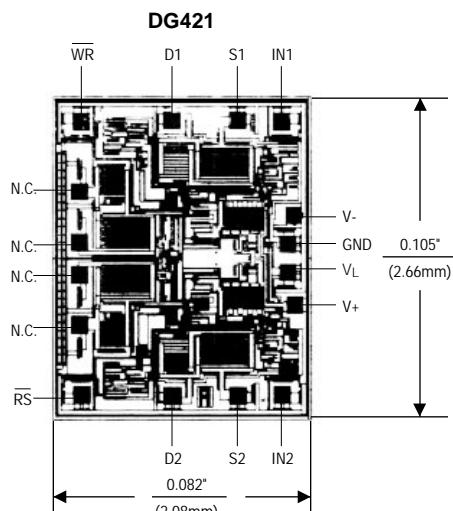
_Ordering Information (continued)

PART	TEMP. RANGE	PIN-PACKAGE
DG423CJ	0°C to +70°C	16 Plastic DIP
DG423CY	0°C to +70°C	16 SO
DG423C/D	0°C to +70°C	Dice*
DG423DJ	-40°C to +85°C	16 Plastic DIP
DG423DY	-40°C to +85°C	16 SO
DG423DN	-40°C to +85°C	20 PLCC
DG423DK	-40°C to +85°C	16 CERDIP
DG423AK	-55°C to +125°C	16 CERDIP**
DG425CJ	0°C to +70°C	16 Plastic DIP
DG425CY	0°C to +70°C	16 SO
DG425C/D	0°C to +70°C	Dice*
DG425DJ	-40°C to +85°C	16 Plastic DIP
DG425DY	-40°C to +85°C	16 SO
DG425DN	-40°C to +85°C	20 PLCC
DG425DK	-40°C to +85°C	16 CERDIP
DG425AK	-55°C to +125°C	16 CERDIP**

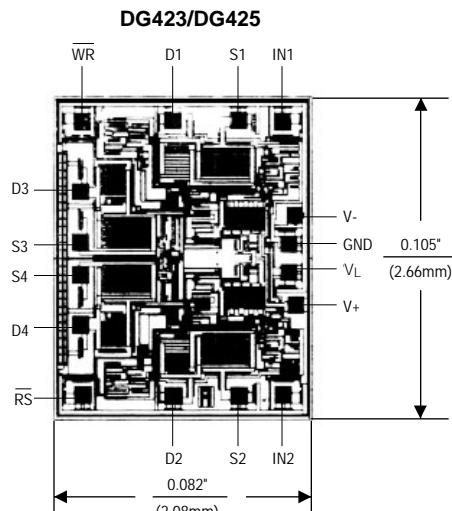
* Contact factory for dice specifications.

**Contact factory for availability and processing to MIL-STD-883B.

Chip Topographies



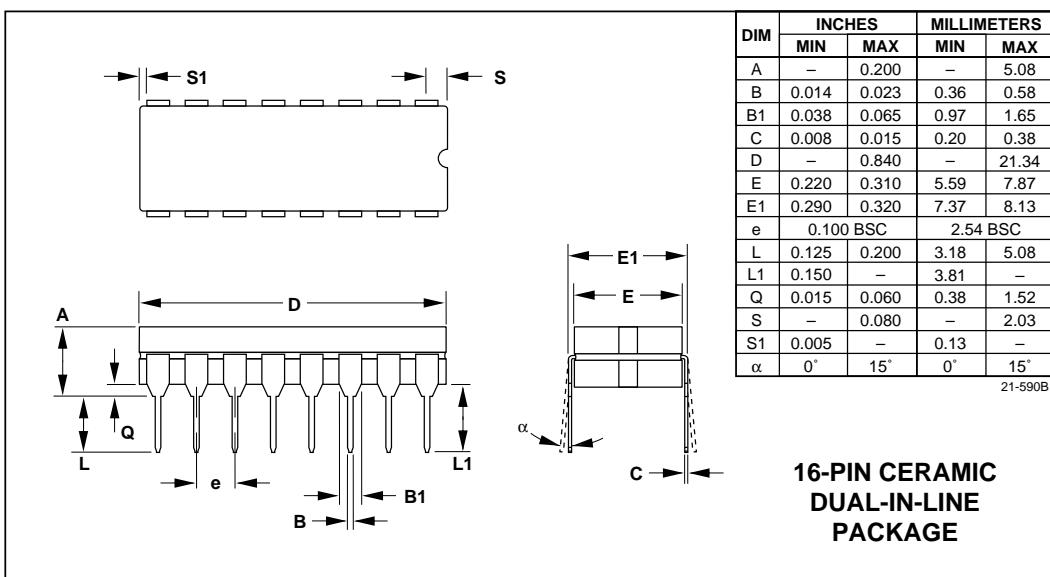
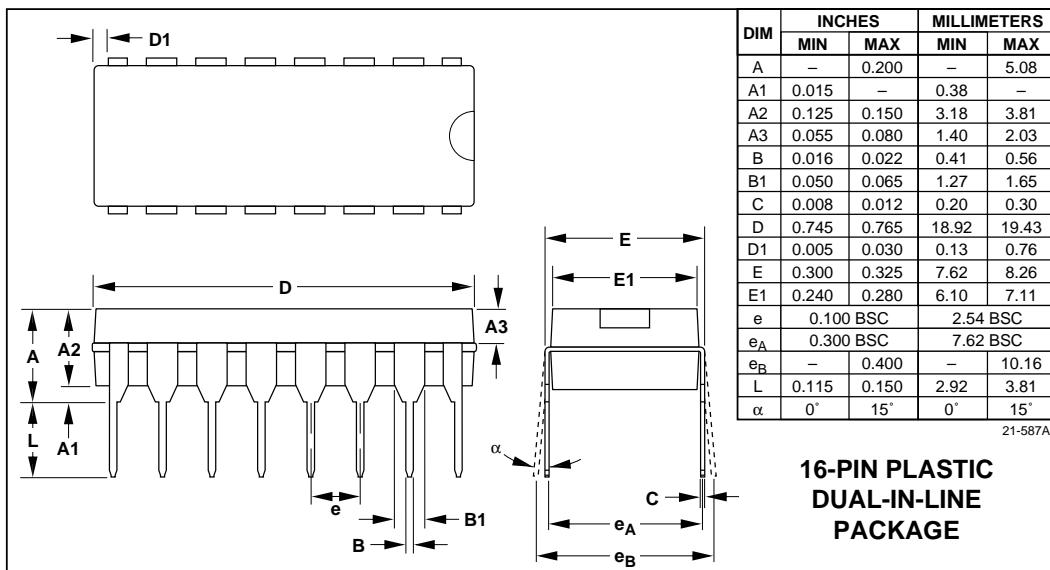
TRANSISTOR COUNT: 100
SUBSTRATE CONNECTED TO V+



TRANSISTOR COUNT: 100
SUBSTRATE CONNECTED TO V+

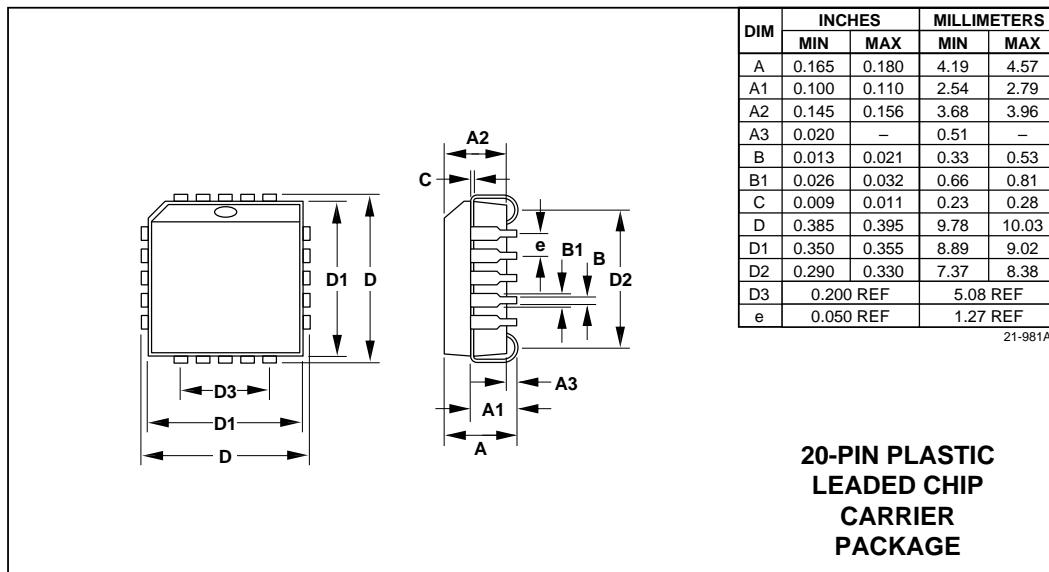
Improved Low-Power, CMOS Analog Switches with Latches

Package Information



Improved Low-Power, CMOS Analog Switches with Latches

Package Information (continued)



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